## Notice of References Cited Application/Control No. | Applicant(s)/Patent Under | Reexamination | OGAWA ET AL. | Examiner | Art Unit | Page 1 of 1

## **U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-5,999,504	12-1999	Aoki, Ikuo	369/47.4
*	В	US-5,862,123	01-1999	Horie et al.	369/275.4
*	С	US-2002/0051416	05-2002	Suzuki, Yuki	369/59.12
*	D	US-6,487,164	11-2002	Endoh et al.	369/275.4
*	E	US-2002/0131352	09-2002	Kuribayashi et al.	369/47.17
*	F	US-2003/0103429	06-2003	Senshu, Susumu	369/47.24
	G	US-			
	Н	US-			·
	1	US-			
	J	US-			
	К	US-			
	L	US-			
	М	US-			

## **FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
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	P	·				
	Q					
	R			:		
	s				14.7	
	Т	9				

## **NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)

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